Express Mail Label No.: EV062336985US Atto

Attorney Docket No.: N1085-00127 [TSMC 2002-0989]

What is claimed is:

1 1. In a method for performing failure analysis on a printed circuit board having a circuit

- 2 trace thereon and a solder mask over the circuit trace, the improvement comprising:
- 3 removing the solder mask from the printed circuit board using an ultra violet laser, to
- 4 expose the circuit trace without damaging the circuit trace.
- 1 2. The method of claim 1, wherein the ultraviolet laser has a wavelength of from about 3
- 2 nanometers to about 400 nanometers.
- 1 3. The method of claim 1, wherein the ultraviolet laser has a wavelength from the group
- 2 consisting of 355 nanometers and 266 nanometers.
- 1 4. The method of claim 1, wherein the ultraviolet laser is one of the group consisting of a
- 2 solid state laser, a gas laser, a dye laser, and an excimer laser.
- 1 5. The method of claim 4, wherein the ultraviolet laser is a yttrium aluminum garnet laser.
- 1 6. The method of claim 1, wherein the solder mask comprises an organic compound.
- The method of claim 1, wherein the solder mask comprises a thermosetting resin.
- 1 8. The method of claim 7, wherein the solder mask comprises a film selected from the group
- 2 consisting of polyimide and cyanate ester resins and a dual solution photo-curing type material
- 3 containing an unsaturated resin that includes carboxylic acid and a polyepoxy compound.
- 1 9. A method comprising the steps of:
- 2 providing a printed circuit board having a circuit trace thereon and a solder mask over the
- 3 circuit trace;
- 4 removing the solder mask from the printed circuit board using an ultra violet laser, to
- 5 expose the circuit trace without damaging the circuit trace; and
- 6 performing failure analysis on the circuit trace of the printed circuit board.

Express Mail Label No.: EV062336985US Attorney Docket No.: N1085-00127 [TSMC 2002-0989]

1 10. The method of claim 8, wherein the ultraviolet laser has a wavelength of from about 3

- 2 nanometers to about 400 nanometers.
- 1 11. The method of claim 9, wherein the ultraviolet laser has a wavelength from the group
- 2 consisting of 355 nanometers and 266 nanometers.
- 1 12. The method of claim 9, wherein the ultraviolet laser is one of the group consisting of a
- 2 solid state laser, a gas laser, a dye laser, and an excimer laser.
- 1 13. The method of claim 12, wherein the ultraviolet laser is a yttrium aluminum garnet laser.
- 1 14. The method of claim 9, wherein the solder mask comprises an organic compound.
- 1 15. The method of claim 9, wherein the solder mask comprises a thermosetting resin.
- 1 16. The method of claim 15, wherein the solder mask comprises a film selected from the
- 2 group consisting of polyimide and cyanate ester resins and a dual solution photo-curing type
- 3 material containing an unsaturated resin that includes carboxylic acid and a polyepoxy
- 4 compound.
- 1 17. A printed circuit board suitable for failure analysis, the printed circuit board being
- 2 prepared by a method comprising the steps of:
- providing a printed circuit board having a circuit trace thereon and a solder mask over the
- 4 circuit trace;
- 5 removing the solder mask from the printed circuit board using an ultra violet laser, to
- 6 expose the circuit trace without damaging the circuit trace, thereby readying the printed circuit
- 7 board for performing failure analysis on the circuit trace thereof.
- 1 18. The printed circuit board of claim 17, wherein the ultraviolet laser has a wavelength of
- 2 from about 3 nanometers to about 400 nanometers.

Express Mail Label No.: EV062336985US Attorney Doc

Attorney Docket No.: N1085-00127 [TSMC 2002-0989]

1 19. The printed circuit board of claim 17, wherein the ultraviolet laser has a wavelength from

- the group consisting of 355 nanometers and 266 nanometers.
- 1 20. The printed circuit board of claim 17, wherein the ultraviolet laser is one of the group
- 2 consisting of a solid state laser, a gas laser, a dye laser, and an excimer laser.
- 1 21. The printed circuit board of claim 20, wherein the ultraviolet laser is a yttrium aluminum
- 2 garnet laser.
- 1 22. The printed circuit board of claim 17, wherein the solder mask comprises an organic
- 2 compound.
- 1 23. The method of claim 17, wherein the solder mask comprises a thermosetting resin.
- 1 24. The printed circuit board of claim 23, wherein the solder mask comprises a film selected
- 2 from the group consisting of polyimide and cyanate ester resins and a dual solution photo-curing
- 3 type material containing an unsaturated resin that includes carboxylic acid and a polyepoxy
- 4 compound.
- 1 25. A device suitable for failure analysis, the device being prepared by a method comprising
- 2 the steps of:
- providing a substrate having a circuit trace thereon and a solder mask over the circuit
- 4 trace;
- 5 removing the solder mask from the substrate using an ultra violet laser, to expose the
- 6 circuit trace without damaging the circuit trace, thereby readying the substrate for performing
- 7 failure analysis on the circuit trace thereof.
- 1 26. The device of claim 25, wherein the ultraviolet laser has a wavelength of from about 3
- 2 nanometers to about 400 nanometers.

Express Mail Label No.: EV062336985US Attorney Docket No.: N1085-00127 [TSMC 2002-0989]

1 27. The device of claim 25, wherein the ultraviolet laser has a wavelength from the group

- 2 consisting of 355 nanometers and 266 nanometers.
- 1 28. The device of claim 25, wherein the ultraviolet laser is one of the group consisting of a
- 2 solid state laser, a gas laser, a dye laser, and an excimer laser.
- 1 29. The device of claim 28, wherein the ultraviolet laser is a yttrium aluminum garnet laser.
- 1 30. The device of claim 25, wherein the solder mask comprises an organic compound.
- 1 31. The device of claim 25, wherein the solder mask comprises a thermosetting resin.
- 1 32. The device of claim 25, wherein the solder mask comprises a film selected from the
- 2 group consisting of polyimide and cyanate ester resins and a dual solution photo-curing type
- 3 material containing an unsaturated resin that includes carboxylic acid and a polyepoxy
- 4 compound.